Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/792,043	YAN ET AL.	
Examiner	Art Unit	
Helen C. Kwok	2856	

	SEAR	CHED	
Class	Subclass	Date	Examiner

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
73	504.14	7/22/2005	НК
73	504.04	7/22/2005	нк
·			

SEARCH (INCLUDING SEAR		')
	DATE	EXMR
Updated Previous Search	7/22/2005	нк
-		
· · · · · · · · · · · · · · · · · · ·	;	